

(19)



Europäisches Patentamt
European Patent Office
Office européen des brevets

(11) Publication number:

0 381 517
A2

(12)

EUROPEAN PATENT APPLICATION

(21) Application number: 90301112.0

(31) Int. Cl.⁵ G01T 1/24, G01T 1/26

(22) Date of filing: 02.02.90

(30) Priority: 03.02.89 GB 8902443

(43) Date of publication of application:
08.08.90 Bulletin 90/32(54) Designated Contracting States:
CH DE FR GB LI SE

(71) Applicant: DE BEERS INDUSTRIAL DIAMOND
DIVISION (PROPRIETARY) LIMITED
8th Floor 45 Main Street
Johannesburg Transvaal(ZA)

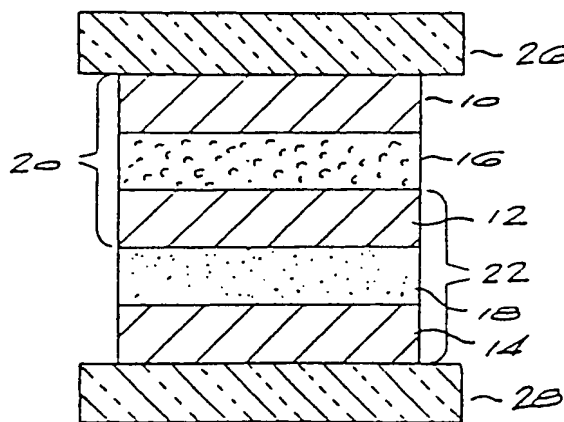
(72) Inventor: Jones, Barbara Lynn
80 Chisbury Place Forest Park
Bracknell, RG12 3TX(GB)

(74) Representative: Senior, Alan Murray et al
J.A. KEMP & CO 14 South Square Gray's Inn
London WC1R 5EU(GB)

(54) Radiation detector.

(57) A composite radiation detection and indicating device comprises first, third and fifth layers (10,12,14) of a transparent conductive material, a second layer (16) of semiconductive diamond between the first and third layers, and a fourth layer (18) of liquid crystal material between the third and fifth layers. The layers are sandwiched together so that a diodic structure (20) having a radiation-dependent charge storage characteristic is defined by the first, second and third layers, and a liquid crystal display element (22) is defined by the third, fourth and fifth layers. The invention extends to a radiation detector including the composite device, together with an oscillator (24) for applying a charge to the diodic structure, and a sensor (T2) for monitoring the decay of the stored charge. A voltage is applied to the liquid crystal display element (22) to cause it to change state when the charge stored by the diodic structure decays below a predetermined limit.

Fig. 1



EP 0 381 517 A2

RADIATION DETECTOR

This invention relates to a radiation detector which is sensitive to nuclear radiation.

According to the invention a composite radiation detection and indicating device comprises first, third and fifth layers of a transparent conductive material, a second layer of transparent semiconductive material between the first and third layers, and a fourth layer of liquid crystal material between the third and fifth layers, the layers being sandwiched together so that a diodic structure having a radiation-dependent charge storage characteristic is defined by the first, second and third layers, and a liquid crystal display element is defined by the third, fourth and fifth layers.

The transparent semiconductive material preferably comprises diamond.

The transparent conductive material may be, for example, tin oxide.

Further according to the invention radiation detection apparatus comprises a composite radiation detection element of the invention, bias means for applying a predetermined charge to the diodic structure of the composite device, monitoring means for monitoring the decay of the stored charge, and means for applying a voltage to the liquid crystal display element to cause it to change state when the charge stored by the diodic structure decays below a predetermined limit.

The bias means may be adapted to charge the diodic structure repetitively at a predetermined rate, the monitoring means being adapted to be reset at the same rate, so that the monitoring means effectively measures the rate of decay of the charge stored by the diodic structure.

The monitoring means preferably comprises a MOSFET transistor having a very high input impedance, so that the charge storage characteristics of the diode are not substantially affected thereby in use.

Figure 1 is a schematic illustration of the construction of a composite radiation detection and indicating device according to the invention; and

Figure 2 is a schematic circuit diagram of radiation detection apparatus according to the invention.

The composite radiation detection and indicating device illustrated in Figure 1 comprises three layers 10, 12 and 14 of tin oxide (SnO_2). Sandwiched between the layers 10 and 12 is a diamond layer 16, and sandwiched between the layers 12 and 14 is a layer 18 of liquid crystal material. The layers 10, 16 and 12 together define a back-to-back diodic structure 20, while the layers 12, 18 and 14 together define a liquid crystal display element 22. Outer protective layers 26 and 28 of

transparent glass protect and support the diode/display structure, making it sufficiently rigid to be self-supporting. The choice of diamond for the layer 16 is determined by the fact that a substantially transparent semiconductive layer is readily provided using diamond. However, other transparent semiconductive materials could be used instead.

It should be appreciated that the illustration of Figure 1 is purely schematic and is not to scale.

Typically, the radiation detection element has a width of 5mm, with a diamond layer 16 of approximately $10\mu\text{m}$ thickness, while the liquid crystal layer 18 has a typical thickness of $7\mu\text{m}$.

The diodic structure 20 has an effective capacitance which is determined by the characteristics of a depletion layer at the diode junction. If the diodic structure is biased electrically and then left open circuit, a charge is stored by this capacitance. The stored charge decays very slowly in the absence of nuclear radiation or a current leakage path. However, when radiation is incident on the diode junction, electron/hole pairs are generated at a rate which is proportional to the intensity of the incident radiation, and the stored charge is dissipated at a corresponding rate.

The circuit illustrated schematically in Figure 2 shows the diodic structure 20 and the liquid crystal element 22 as independent circuit elements. This is made possible because the common "terminal" of the two devices, formed by the tin oxide layer 12, is effectively at earth or ground potential in both devices. The illustrated circuit includes a pair of MOSFET transistors T1 and T2. It is particularly important that the transistor T2 should have a high input impedance. The source of the transistor T1 is held at a constant negative voltage V1, so that when the transistor is on, the diodic structure 20 is reverse biased. A square waveform V2 is applied to the gate of the transistor T1 by a variable oscillator circuit 24, which generates a square waveform at a selected frequency and having a desired duty cycle. This effectively switches the transistor T1 on and off at a predetermined rate, repetitively applying a predetermined charge to the diodic structure 20 via the layer 10.

The transistor T2 acts as a monitoring or sampling device for monitoring the level of charge on the diodic structure 20. The high input impedance of this transistor ensures that it does not bleed off a significant amount of charge from the diodic structure. The drain of the transistor T2 is held at constant voltage V3 which is greater than 2V. The drain of the transistor T2 is connected via a capacitor C to the layer 14 of the liquid crystal display

element 22.

When the diodic structure 20 is subjected to nuclear radiation, its stored charge is dissipated at a rate proportional to the intensity of the incident radiation. As the level of charge reduces, the transistor T2 begins to turn on, allowing the capacitor C to charge towards the voltage V3. As the voltage on the capacitor approaches 2V, the liquid crystal display element 22 will turn on (that is, darken) indicating that a predetermined radiation intensity is being detected.

As illustrated, the oscillator circuit 24 will reset the liquid crystal display and re-charge the diodic structure at the oscillator frequency f_1 . This means that if the intensity of the incident nuclear radiation is below a level determined by, inter alia, the oscillator frequency f_1 , the diodic structure will be recharged before it discharges sufficiently to activate the display. Effectively, therefore, the rate of decay of the charge stored by the diodic structure is measured. It is also possible to provide a latching circuit which will keep the liquid crystal display turned on for a desired length of time after a predetermined radiation level has been detected.

The described radiation detection indicating element can be manufactured as a single device due to the fact that the diamond layer 16 is transparent and does not obscure the liquid crystal layer 18.

Due to its relatively small size and thickness, the device can be incorporated in a credit-card sized personal radiation detector, for example. In such an application, the associated electronic components can be placed or formed directly on the substrate of the card, for example, by thin-film technology. Alternatively, of course, discrete electronic components can be used. Another application of the device is in a "wrist-watch" type of radiation detector, in which the device of the invention is incorporated in a small housing with a strap attached thereto.

Claims

1. A composite radiation detection and indicating device characterised in that it comprises first, third and fifth layers (10,12,14) of a transparent conductive material, a second layer (16) of transparent semiconductive material between the first and third layers, and a fourth layer (18) of liquid crystal material between the third and fifth layers, the layers being sandwiched together so that a diodic structure (20) having a radiation-dependent charge storage characteristic is defined by the first, second and third layers, and a liquid crystal display element (22) is defined by the third, fourth and fifth layers.

2. A composite device according to claim 1 characterised in that the layer (16) of transparent semiconductive material comprises diamond.

3. A composite device according to claim 1 or 2 characterised in that the layers (10, 12, 14) of transparent conductive material comprise tin oxide.

4. A composite device according to any one of claims 1 to 3 characterised in that protective layers (26, 28) of glass are applied to the outer surfaces of the device.

5. Radiation detection apparatus comprising a composite radiation detection and indicating device according to any one of claims 1 to 4, characterised in that further comprises bias means (24, T1) for applying a predetermined charge to the diodic structure (20) of the composite device, monitoring means (T2) for monitoring the decay of the stored charge, and means (C) for applying a voltage to the liquid crystal display element (22) to cause it to change state when the charge stored by the diodic structure decays below a predetermined limit.

6. Radiation detection apparatus according to claim 5 characterised in that the bias means (24, T1) is adapted to charge the diodic structure (20) repetitively at a predetermined rate, the monitoring means (T2) being adapted to be reset at the same rate, so that the monitoring means effectively measures the rate of decay of the charge stored by the diodic structure.

7. Radiation detection apparatus according to claim 6 characterised in that the bias means (24, T1) includes an oscillator (24) operating at a predetermined frequency and duty cycle.

8. Radiation detection apparatus according to claim 7 characterised in that the bias means (24, T1) further includes switch means (T1) for applying the oscillator output to the diodic structure (20) to charge the diodic structure.

9. Radiation detection apparatus according to claim 8 characterised in that the switch means (T1) comprises a MOSFET transistor.

10. Radiation detection apparatus according to claim 9 characterised in that the monitoring means (T2) comprises a MOSFET transistor having a very high input impedance, so that the charge storage characteristics of the diodic structure (20) are not substantially affected thereby in use.

11. Radiation detection apparatus according to any one of claims 5 to 10 characterised in that the third layer (12) of the composite device serves as a common terminal of the diodic structure (20) and of the liquid crystal display element (22).

Neu eingereicht / Newly filed
Nouvellement déposé

FIG. 1

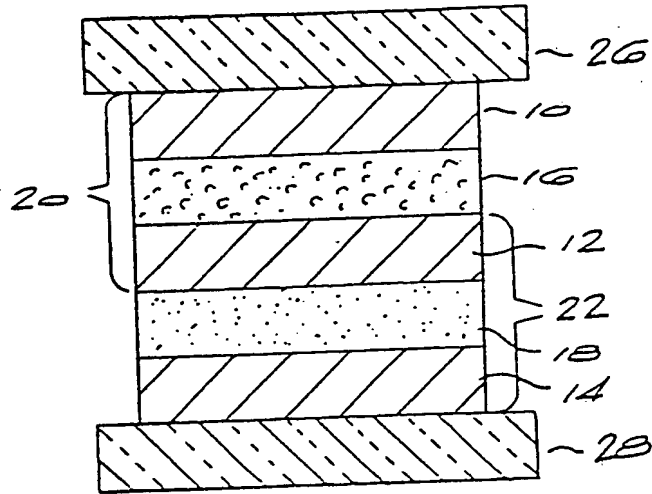
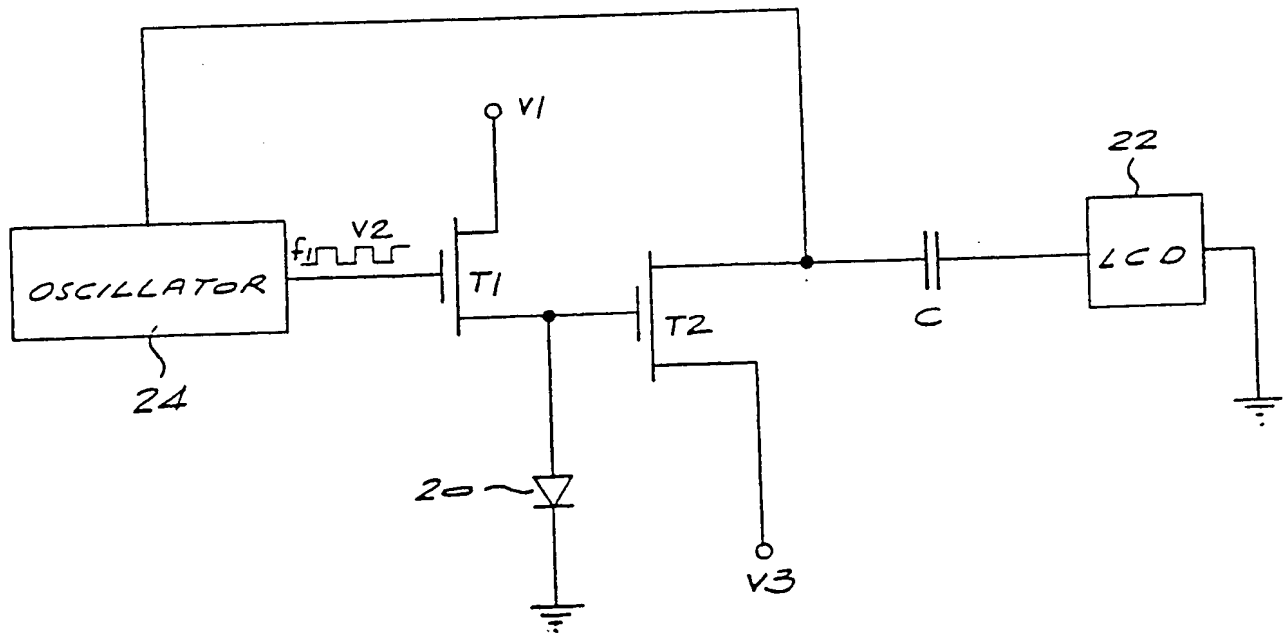


FIG. 2





Europäisches Patentamt
European Patent Office
Office européen des brevets



Publication number:

0 381 517 A3

12

EUROPEAN PATENT APPLICATION

21 Application number: 90301112.0

51 Int. Cl.⁵: G01T 1/26

22 Date of filing: 02.02.90

30 Priority: 03.02.89 GB 8902443

43 Date of publication of application:
08.08.90 Bulletin 90/32



84 Designated Contracting States:
CH DE FR GB LI SE

88 Date of deferred publication of the search report:
02.01.92 Bulletin 92/01

71 Applicant: DE BEERS INDUSTRIAL DIAMOND

DIVISION (PROPRIETARY) LIMITED
8th Floor 45 Main Street
Johannesburg Transvaal(ZA)

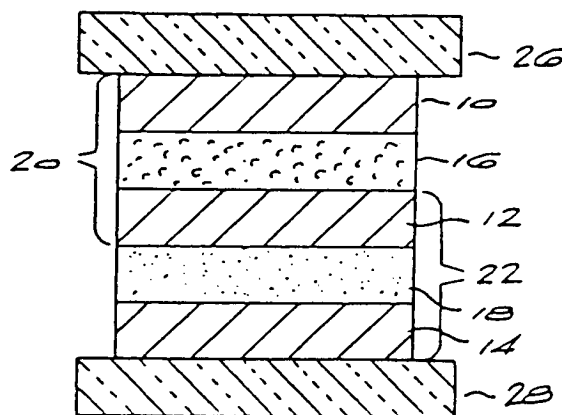
72 Inventor: Jones, Barbara Lynn
80 Chisbury Place Forest Park
Bracknell, RG12 3TX(GB)

74 Representative: Senior, Alan Murray et al
J.A. KEMP & CO 14 South Square Gray's Inn
London WC1R 5EU(GB)

54 Radiation detector.

57 A composite radiation detection and indicating device comprises first, third and fifth layers (10,12,14) of a transparent conductive material, a second layer (16) of semiconductive diamond between the first and third layers, and a fourth layer (18) of liquid crystal material between the third and fifth layers. The layers are sandwiched together so that a diodic structure (20) having a radiation-dependent charge storage characteristic is defined by the first, second and third layers, and a liquid crystal display element (22) is defined by the third, fourth and fifth layers. The invention extends to a radiation detector including the composite device, together with an oscillator (24) for applying a charge to the diodic structure, and a sensor (T2) for monitoring the decay of the stored charge. A voltage is applied to the liquid crystal display element (22) to cause it to change state when the charge stored by the diodic structure decays below a predetermined limit.

FIG. 1





European
Patent Office

EUROPEAN SEARCH REPORT

Application Number

EP 90 30 1112

DOCUMENTS CONSIDERED TO BE RELEVANT

Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int. Cl.5)
A	EP-A-0 029 379 (THOMSON-CSF) * Abstract; page 2, line 11 - page 3, line 10; page 4, lines 1-5; figure 1 *	1,5	G 01 T 1/26
A	EP-A-0 250 252 (DE BEERS) * Abstract; fig. *	1,2	
A	US-A-3 967 253 (T. YUKI) * Abstract; column 2, line 55 - column 3, line 57; claim 1; fig. *	1,4,5,9	
			TECHNICAL FIELDS SEARCHED (Int. Cl.5)
			G 01 T H 03 K
The present search report has been drawn up for all claims			
Place of search		Date of completion of search	Examiner
The Hague		24 October 91	DATTA S.
CATEGORY OF CITED DOCUMENTS X: particularly relevant if taken alone Y: particularly relevant if combined with another document of the same category A: technological background O: non-written disclosure P: intermediate document T: theory or principle underlying the invention E: earlier patent document, but published on, or after the filing date D: document cited in the application L: document cited for other reasons &: member of the same patent family, corresponding document			